## Application/Control No. Applicant(s)/Patent Under Reexamination 09/551,187 ZENG, JUN Notice of References Cited Art Unit Examiner Page 1 of 1 2822 Michael Trinh **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-4,597,166 07-1986 Iwai, Hiroshi 438/476 Α В US-С US-US-D US-Ε US-F US-G US-Н ı US-US-

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